# Sequential Double Ionization of Ar to Ar2+Over Intense Laser Field Pulses

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## Three Step Model



## Sequential Double Ionization



#### Laser Profiles

Intensities above 1x10<sup>15</sup> W/cm<sup>2</sup> are too difficult to distinguish

We need a program to calibrate these profiles



Kim, Kyungbum, Peng, Xiang & Lee, Proceedings of SPIE - The International Society for Optical Engineering , (2014)

### Pathway from Ar to Ar2+

Electric Field >> Ionization Rate



Step 1

#### Ammosov-Delone-Krainov theory plus modification:

$$W_{TI}(F) = \frac{C_{I}^{2}}{2^{|m|}|m|!} \frac{(2l+1)(l+|m|)!}{2(l-|m|)!} \frac{1}{\kappa^{22}c^{|\kappa-1|}} \left(\frac{2\kappa^{3}}{F}\right)^{\frac{22c}{\kappa-|m|-1}} e^{-2\kappa^{3}/3F}$$
  
$$W_{TBI}(F) = W_{TI} e^{-\phi(2c^{2}/1P)(F|\kappa^{3})}$$

Step 2

Method 1

Method 2

$$\frac{dP_{o}}{dt} = -P_{o}(t)W_{o}(t)$$

$$\int \frac{dP_{o}}{P_{o}(t)} = -\int W_{o}(t)dt$$

$$Ar: \frac{dP_{o}}{dt} = -P_{o}(t)W_{o}(t)$$

$$\int W_{o}(t)dt$$

$$Ar: \frac{dP_{i}}{dt} = -P_{i}(t)W_{i}(t) + P_{o}(t)W_{o}(t)$$

$$\frac{P_{i} \times P_{2}}{P_{i}}$$

$$Ar 2t: \frac{dP_{2}}{dt} = P_{i}(t)W_{i}(t)$$

$$P_{o}(0) = I$$

$$P_{i}(0) = 0$$





Lin, C.D., Yuen, I., Physical Review 023120 (2022)

### Step 3

# What happens as we increase the intensity?



Kubel, M. et al. Physical Review A 053422-2 (2016)

### Finish Line

Goal: Determine probability of ionization given laser pulse parameters

#### Future Work:

- Determine cause of error in Method 2
- Test other parameters
- Test other elements



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